Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/611,339	FENG ET AL.	
Examiner	Art Unit	
Thuan D. Dang	1764	

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Class	Subclass	Date	Examiner
208	134	1/31/2006	TD
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEAI (INCLUDING S	RCH NOTES SEARCH STRATE	GY)
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